

# FGH60N60SFD 600 V, 60 A Field Stop IGBT

### Features

- High Current Capability
- Low Saturation Voltage: V<sub>CE(sat)</sub> = 2.3 V @ I<sub>C</sub> = 60 A
- High Input Impedance
- Fast Switching
- RoHS Compliant

### Applications

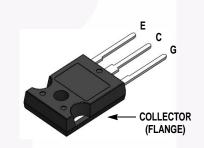
• Solar Inverter, UPS, Welder, PFC

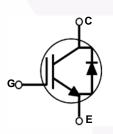
#### March 2015



## **General Description**

Using novel field stop IGBT technology, Fairchild's field stop IGBTs offer the optimum performance for solar inverter, UPS, welder and PFC applications where low conduction and switching losses are essential.





#### **Absolute Maximum Ratings**

Symbol	Description		Ratings	Unit	
V <sub>CES</sub>	Collector to Emitter Voltage		600	V	
V <sub>GES</sub>	Gate to Emitter Voltage   Transient Gate-to-Emitter Voltage		±20	V	
			±30	v	
I <sub>C</sub>	Collector Current	@ T <sub>C</sub> = 25°C	120	A	
	Collector Current	@ T <sub>C</sub> = 100 <sup>o</sup> C	60	A	
I <sub>CM (1)</sub>	Pulsed Collector Current	@ T <sub>C</sub> = 25°C	180	A	
P <sub>D</sub>	Maximum Power Dissipation	@ T <sub>C</sub> = 25°C	378	W	
	Maximum Power Dissipation	@ T <sub>C</sub> = 100 <sup>o</sup> C	151	W	
Т <sub>Ј</sub>	Operating Junction Temperature	perating Junction Temperature		°C	
T <sub>stg</sub>	Storage Temperature Range		-55 to +150	°C	
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 second	s	300	°C	

Notes:

1: Repetitive test, Pulse width limited by max. juntion temperature

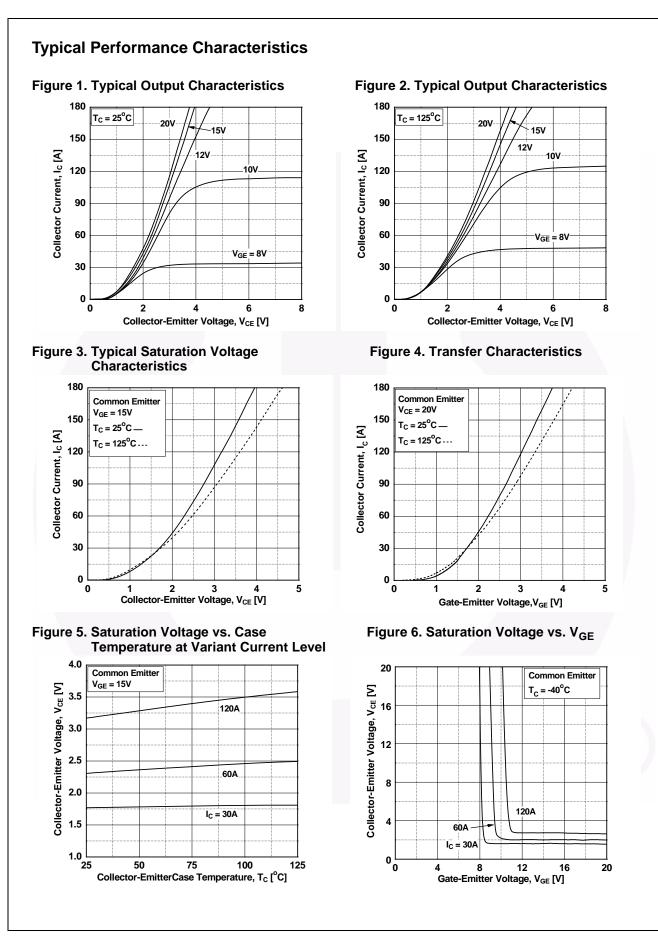
## **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction to Case	-	0.33	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case	-	1.1	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	-	40	°C/W

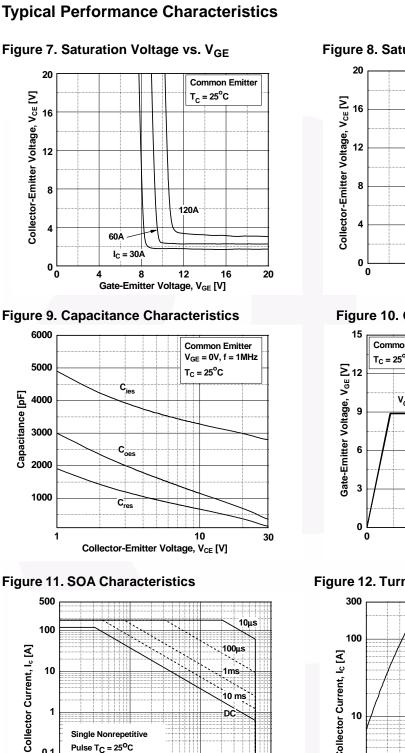
Part NumberTop MarkPackageFGH60N60SFDTUFGH60N60SFDTO-247		er Top Mark	Package	Packing Method	Reel Size	Tape Wid	lth Q	Quantity	
		Tube	N/A	N/A		30			
Electric	al Ch	aracteristics	s of the IC	<b>GBT</b> $T_{C} = 25^{\circ}C$ unless other	wise noted				
Symbol		Parameter	•	Test Conditio	ns Min	. Typ.	Max.	Unit	
Off Charac	teristics					ŧ	1		
BV <sub>CES</sub>	Collector to Emitter Breakdown Voltage		V <sub>GE</sub> = 0 V, I <sub>C</sub> = 250 μA	600	) _	-	V		
$\Delta BV_{CES}$ / $\Delta T_J$	Temperature Coefficient of Breakdown		$V_{GE} = 0 V, I_C = 250 \mu A$	-	0.4	_	V/°C		
	-	Voltage Collector Cut-Off Current		V <sub>CE</sub> = V <sub>CES</sub> , V <sub>GE</sub> = 0 V	-	_	250	μA	
				$V_{CE} = V_{CES}, V_{GE} = 0.V$ $V_{GE} = V_{GES}, V_{CE} = 0.V$		-	±400	nA	
IGES	G-E Leakage Current		•GE = •GES, •CE = 0 •			<u> </u>	11/4		
On Charac	teristics								
V <sub>GE(th)</sub>	G-E Th	reshold Voltage		$I_C = 250 \ \mu\text{A}, \ V_{CE} = V_{GE}$	4.0	5.0	6.5	V	
			$I_{C} = 60 \text{ A}, V_{GE} = 15 \text{ V}$	-	2.3	2.9	V		
V <sub>CE(sat)</sub>	Collecto	ector to Emitter Saturation Voltage		$I_{C} = 60 \text{ A}, V_{GE} = 15 \text{ V},$ $T_{C} = 125^{\circ}\text{C}$		2.5	-	V	
_					H				
Dynamic C	1					0000			
C <sub>ies</sub>	-	apacitance		V <sub>CE</sub> = 30 V, V <sub>GE</sub> = 0 V,	-	2820	-	pF	
C <sub>oes</sub>	-	Capacitance		f = 1 MHz	-	350	-	pF	
C <sub>res</sub>	Revers	e Transfer Capacita	ance		-	140	-	pF	
Switching	Charact	eristics							
t <sub>d(on)</sub>	1	n Delay Time			-	22	-	ns	
t <sub>r</sub>	Rise Ti	me			-	42	-	ns	
t <sub>d(off)</sub>	Turn-O	ff Delay Time		V <sub>CC</sub> = 400 V, I <sub>C</sub> = 60 A,	-	134	-	ns	
t <sub>f</sub>	Fall Tim			$R_G = 5 \Omega$ , $V_{GE} = 15 V$ ,	-	31	62	ns	
E <sub>on</sub>	Turn-O	n Switching Loss		Inductive Load, T <sub>C</sub> = 25 <sup>o</sup>	°C	1.79	-	mJ	
E <sub>off</sub>	Turn-O	ff Switching Loss		+	-	0.67	-	mJ	
E <sub>ts</sub>	Total Sv	witching Loss		*	-	2.46	-	mJ	
t <sub>d(on)</sub>	Turn-O	n Delay Time			-	22	-	ns	
t <sub>r</sub>	Rise Ti	me		+	-	44		ns	
t <sub>d(off)</sub>	Turn-O	ff Delay Time		V <sub>CC</sub> = 400 V, I <sub>C</sub> = 60 A,	-	144	-	ns	
t <sub>f</sub>	Fall Tim	ne		$R_{G} = 5 \Omega, V_{GE} = 15 V,$ Inductive Load, $T_{C} = 125$	-	43	-	ns	
E <sub>on</sub>	Turn-O	n Switching Loss			5°C -	1.88	-	mJ	
E <sub>off</sub>	Turn-O	ff Switching Loss		+	-	1.0	- (	mJ	
E <sub>ts</sub>	Total Sv	witching Loss		+	-	2.88	-	mJ	
Q <sub>g</sub>	Total G	ate Charge			-	198	-	nC	
Q <sub>ge</sub>	Gate to	Emitter Charge		$V_{CE} = 400 \text{ V}, I_{C} = 60 \text{ A},$	-	22	-	nC	
Q <sub>gc</sub>	Gate to	Collector Charge		V <sub>GE</sub> = 15 V	-	106	-	nC	

FGH60N
60SFD
- 600 V,
60 A Fiel
ld Stop
IGBT

Symbol	Parameter	Test Conditions		Min.	Тур.	Max	Unit
V <sub>FM</sub>	Diode Forward Voltage	I <sub>F</sub> = 30 A	$T_{\rm C} = 25^{\rm o}{\rm C}$	-	2.0	2.6	V
			$T_{\rm C} = 125^{\rm o}{\rm C}$	-	1.8	-	
t <sub>rr</sub>	Diode Reverse Recovery Time		$T_{\rm C} = 25^{\rm o}{\rm C}$	-	47	-	ns
		I <sub>F</sub> = 30 A, di <sub>F</sub> /dt = 200 A/μs	$T_{\rm C} = 125^{\rm o}{\rm C}$	-	179	-	
Q <sub>rr</sub>	Diode Reverse Recovery Charge	$r_{\rm F} = 30$ Å, $u_{\rm F}/u_{\rm f} = 200$ Å/ $\mu_{\rm S}$	T <sub>C</sub> = 25°C	-	83	-	nC
			$T_{\rm C} = 125^{\rm o}{\rm C}$	-	567	-	



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1ms 10 ms

DC

1000

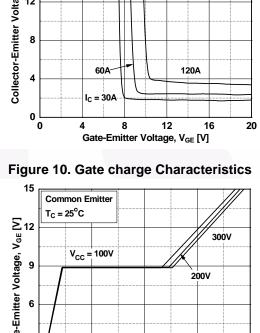
100

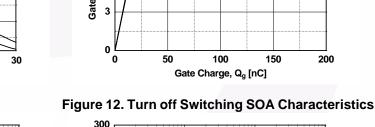
Collector-Emitter Voltage, V<sub>CE</sub> [V]

Figure 8. Saturation Voltage vs. V<sub>GE</sub>

Common Emitter

T<sub>C</sub> = 125<sup>o</sup>C





Collector Current, Ic [A] 10 Safe Operating Area  $V_{GE} = 15V, T_{C} = 125^{\circ}C$ 

Collector-Emitter Voltage, V<sub>CE</sub> [V]

100

10

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10

1

0.1

0.01

1

Single Nonrepetitive Pulse T<sub>C</sub> = 25<sup>o</sup>C

in temperature

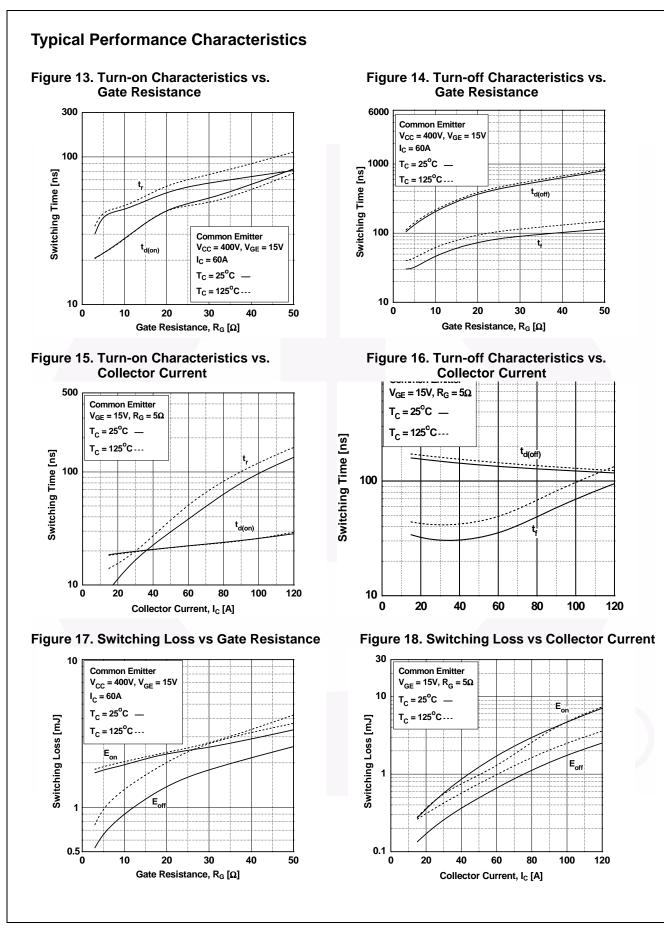
Curves must be derated linearly with increase

10

1

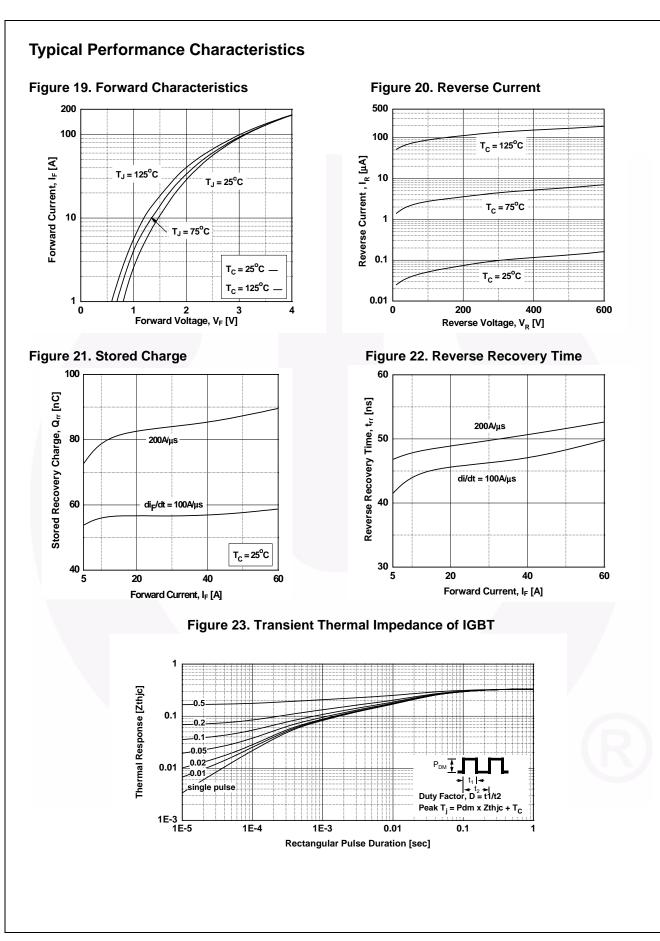
1000

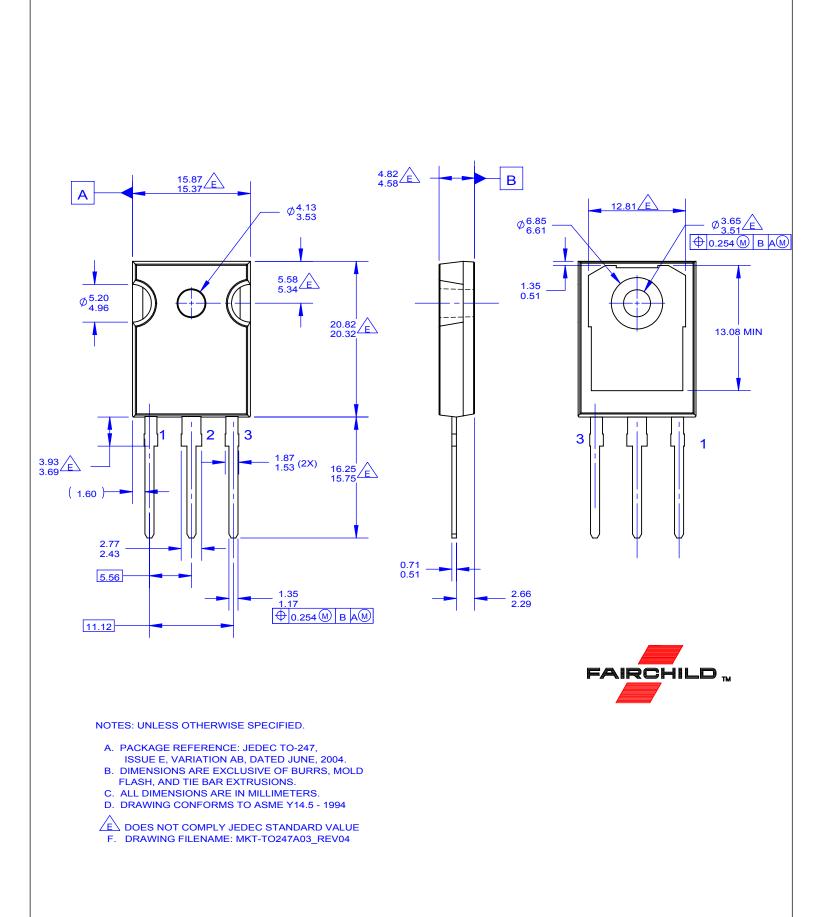
200



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